



## AO3409

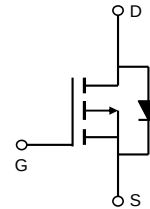
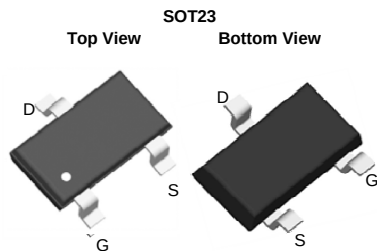
30V P-Channel MOSFET

### General Description

The AO3409 uses advanced trench technology to provide excellent  $R_{DS(ON)}$  and low gate charge. This device is suitable for use as a load switch or in PWM applications.

### Product Summary

|                                   |                 |
|-----------------------------------|-----------------|
| $V_{DS}$                          | -30V            |
| $I_D$ (at $V_{GS}=-10V$ )         | -2.6A           |
| $R_{DS(ON)}$ (at $V_{GS}=-10V$ )  | < 110m $\Omega$ |
| $R_{DS(ON)}$ (at $V_{GS}=-4.5V$ ) | < 180m $\Omega$ |



### Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

| Parameter                              | Symbol         | Maximum    | Units            |
|----------------------------------------|----------------|------------|------------------|
| Drain-Source Voltage                   | $V_{DS}$       | -30        | V                |
| Gate-Source Voltage                    | $V_{GS}$       | $\pm 20$   | V                |
| Continuous Drain Current               | $I_D$          | -2.6       | A                |
| $T_A=25^\circ\text{C}$                 |                | -2.2       |                  |
| Pulsed Drain Current <sup>C</sup>      | $I_{DM}$       | -20        |                  |
| Power Dissipation <sup>B</sup>         | $P_D$          | 1.4        | W                |
|                                        |                | 1          |                  |
| $T_A=25^\circ\text{C}$                 |                |            |                  |
| Junction and Storage Temperature Range | $T_J, T_{STG}$ | -55 to 150 | $^\circ\text{C}$ |

### Thermal Characteristics

| Parameter                                  | Symbol          | Typ | Max | Units              |
|--------------------------------------------|-----------------|-----|-----|--------------------|
| Maximum Junction-to-Ambient <sup>A</sup>   | $R_{\theta JA}$ | 70  | 90  | $^\circ\text{C/W}$ |
| $t \leq 10\text{s}$                        |                 |     |     |                    |
| Maximum Junction-to-Ambient <sup>A,D</sup> | $R_{\theta JA}$ | 100 | 125 | $^\circ\text{C/W}$ |
| Steady-State                               |                 |     |     |                    |
| Maximum Junction-to-Lead                   | $R_{\theta JL}$ | 63  | 80  | $^\circ\text{C/W}$ |
| Steady-State                               |                 |     |     |                    |

Electrical Characteristics ( $T_J=25^{\circ}\text{C}$  unless otherwise noted)

| Symbol                      | Parameter                             | Conditions                                                                           | Min  | Typ       | Max        | Units            |
|-----------------------------|---------------------------------------|--------------------------------------------------------------------------------------|------|-----------|------------|------------------|
| <b>STATIC PARAMETERS</b>    |                                       |                                                                                      |      |           |            |                  |
| $BV_{DSS}$                  | Drain-Source Breakdown Voltage        | $I_D=-250\mu\text{A}$ , $V_{GS}=0\text{V}$                                           | -30  |           |            | V                |
| $I_{DSS}$                   | Zero Gate Voltage Drain Current       | $V_{DS}=-30\text{V}$ , $V_{GS}=0\text{V}$<br>$T_J=55^{\circ}\text{C}$                |      |           | -1<br>-5   | $\mu\text{A}$    |
| $I_{GSS}$                   | Gate-Body leakage current             | $V_{DS}=0\text{V}$ , $V_{GS}=\pm 20\text{V}$                                         |      |           | $\pm 100$  | nA               |
| $V_{GS(th)}$                | Gate Threshold Voltage                | $V_{DS}=V_{GS}$ , $I_D=-250\mu\text{A}$                                              | -1.4 | -1.9      | -2.4       | V                |
| $I_{D(ON)}$                 | On state drain current                | $V_{GS}=-10\text{V}$ , $V_{DS}=-5\text{V}$                                           | -20  |           |            | A                |
| $R_{DS(ON)}$                | Static Drain-Source On-Resistance     | $V_{GS}=-10\text{V}$ , $I_D=-2.6\text{A}$<br>$T_J=125^{\circ}\text{C}$               |      | 77<br>100 | 110<br>140 | $\text{m}\Omega$ |
|                             |                                       | $V_{GS}=-4.5\text{V}$ , $I_D=-2\text{A}$                                             |      | 125       | 180        | $\text{m}\Omega$ |
| $g_{FS}$                    | Forward Transconductance              | $V_{DS}=-5\text{V}$ , $I_D=-2.6\text{A}$                                             |      | 5         |            | S                |
| $V_{SD}$                    | Diode Forward Voltage                 | $I_S=-1\text{A}$ , $V_{GS}=0\text{V}$                                                |      | -0.8      | -1         | V                |
| $I_S$                       | Maximum Body-Diode Continuous Current |                                                                                      |      |           | -1.5       | A                |
| <b>DYNAMIC PARAMETERS</b>   |                                       |                                                                                      |      |           |            |                  |
| $C_{iss}$                   | Input Capacitance                     | $V_{GS}=0\text{V}$ , $V_{DS}=-15\text{V}$ , $f=1\text{MHz}$                          |      | 197       | 240        | pF               |
| $C_{oss}$                   | Output Capacitance                    |                                                                                      |      | 42        |            | pF               |
| $C_{rss}$                   | Reverse Transfer Capacitance          |                                                                                      |      | 26        | 37         | pF               |
| $R_g$                       | Gate resistance                       | $V_{GS}=0\text{V}$ , $V_{DS}=0\text{V}$ , $f=1\text{MHz}$                            | 3.5  | 7.2       | 11.0       | $\Omega$         |
| <b>SWITCHING PARAMETERS</b> |                                       |                                                                                      |      |           |            |                  |
| $Q_g(10\text{V})$           | Total Gate Charge                     | $V_{GS}=-10\text{V}$ , $V_{DS}=-15\text{V}$ , $I_D=-2.6\text{A}$                     |      | 4.3       | 5.2        | nC               |
| $Q_g(4.5\text{V})$          | Total Gate Charge                     |                                                                                      |      | 2.2       | 3          | nC               |
| $Q_{gs}$                    | Gate Source Charge                    |                                                                                      |      | 0.7       |            | nC               |
| $Q_{gd}$                    | Gate Drain Charge                     |                                                                                      |      | 1.1       |            | nC               |
| $t_{D(on)}$                 | Turn-On DelayTime                     | $V_{GS}=-10\text{V}$ , $V_{DS}=-15\text{V}$ , $R_L=5.8\Omega$ ,<br>$R_{GEN}=3\Omega$ |      | 7.5       |            | ns               |
| $t_r$                       | Turn-On Rise Time                     |                                                                                      |      | 4.1       |            | ns               |
| $t_{D(off)}$                | Turn-Off DelayTime                    |                                                                                      |      | 11.8      |            | ns               |
| $t_f$                       | Turn-Off Fall Time                    |                                                                                      |      | 3.8       |            | ns               |
| $t_{rr}$                    | Body Diode Reverse Recovery Time      | $I_F=-2.6\text{A}$ , $dI/dt=100\text{A}/\mu\text{s}$                                 |      | 11.3      | 14         | ns               |
| $Q_{rr}$                    | Body Diode Reverse Recovery Charge    | $I_F=-2.6\text{A}$ , $dI/dt=100\text{A}/\mu\text{s}$                                 |      | 4.4       |            | nC               |

A. The value of  $R_{\theta JA}$  is measured with the device mounted on  $1\text{in}^2$  FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^{\circ}\text{C}$ . The value in any given application depends on the user's specific board design.

B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}=150^{\circ}\text{C}$ , using  $\leq 10\text{s}$  junction-to-ambient thermal resistance.

C. Repetitive rating, pulse width limited by junction temperature  $T_{J(MAX)}=150^{\circ}\text{C}$ . Ratings are based on low frequency and duty cycles to keep initial  $T_J=25^{\circ}\text{C}$ .

D. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to lead  $R_{\theta JL}$  and lead to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using  $<300\mu\text{s}$  pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-ambient thermal impedance which is measured with the device mounted on  $1\text{in}^2$  FR-4 board with 2oz. Copper, assuming a maximum junction temperature of  $T_{J(MAX)}=150^{\circ}\text{C}$ . The SOA curve provides a single pulse rating.

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# TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

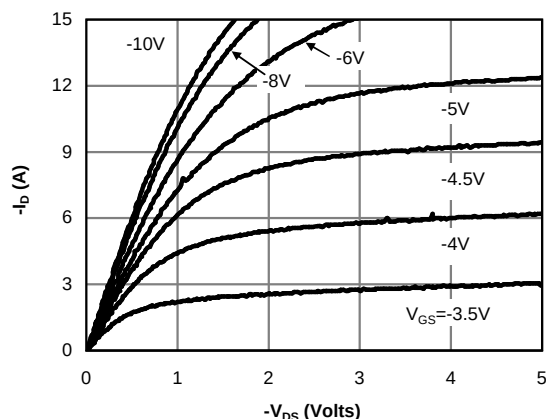


Figure 1: On-Region Characteristics (Note E)

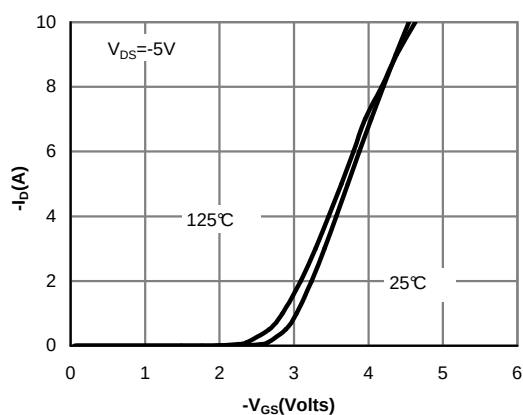


Figure 2: Transfer Characteristics (Note E)

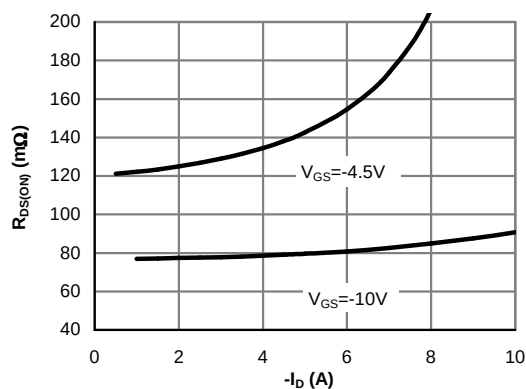


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

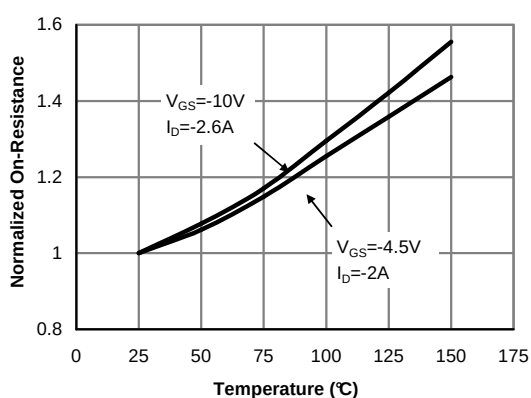


Figure 4: On-Resistance vs. Junction Temperature (Note E)

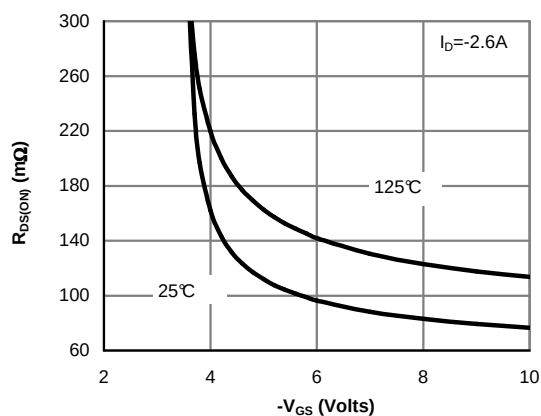


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

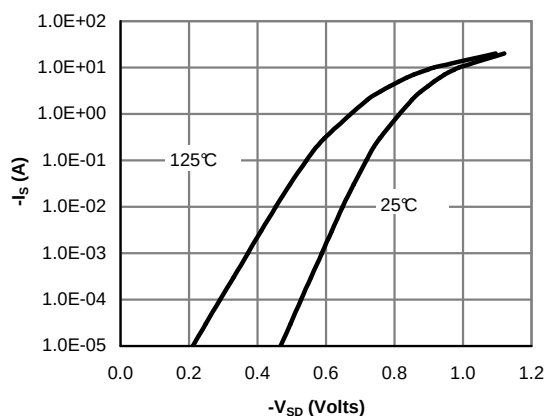


Figure 6: Body-Diode Characteristics (Note E)

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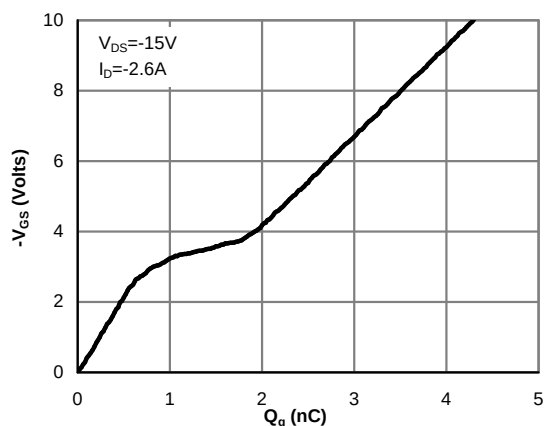


Figure 7: Gate-Charge Characteristics

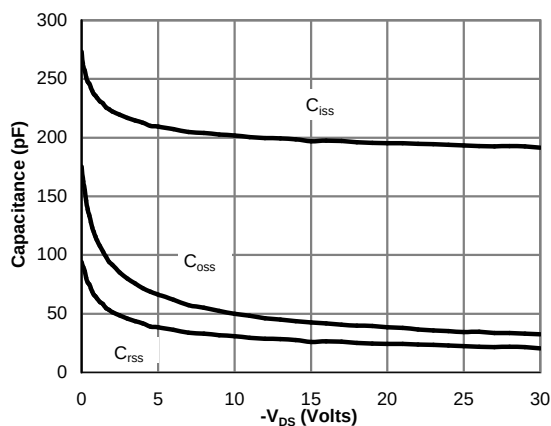


Figure 8: Capacitance Characteristics

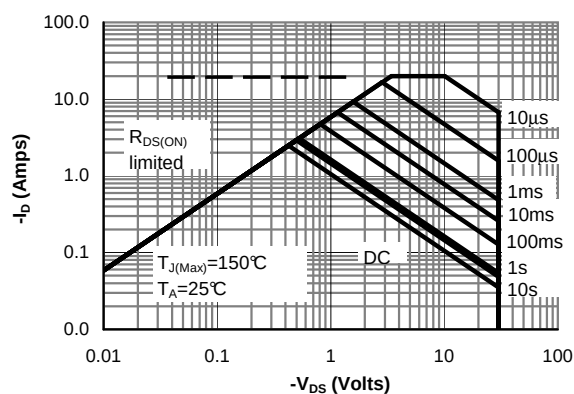


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

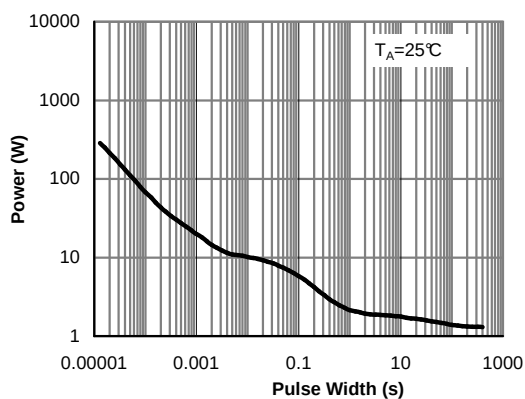


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note F)

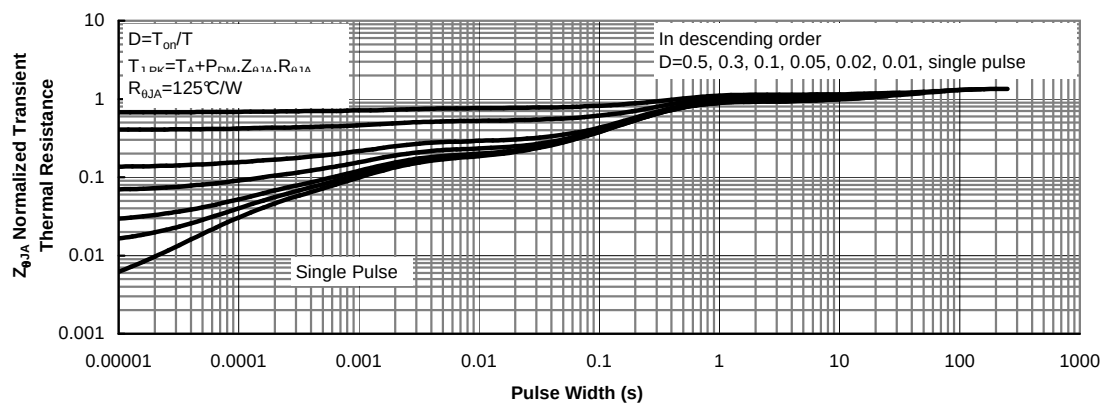
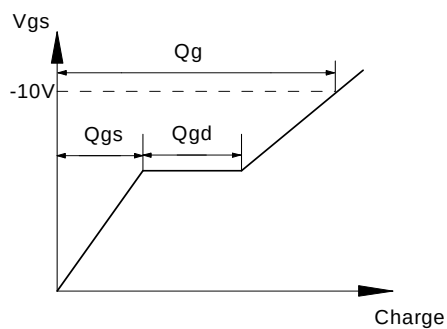
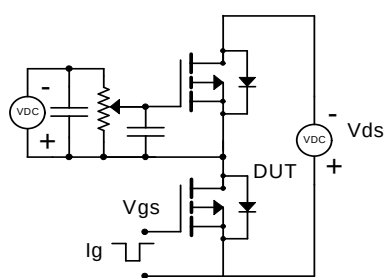
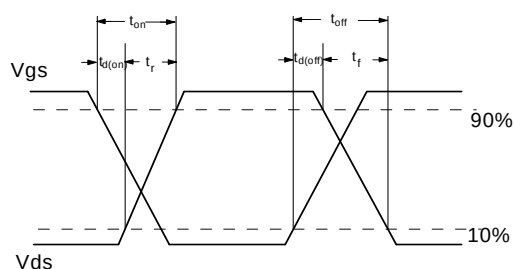
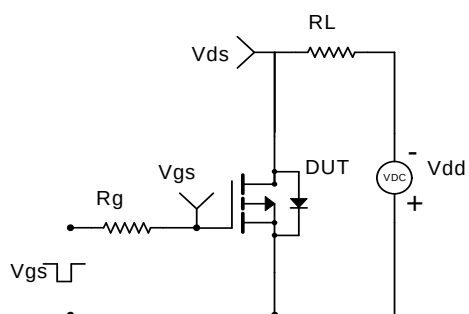


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

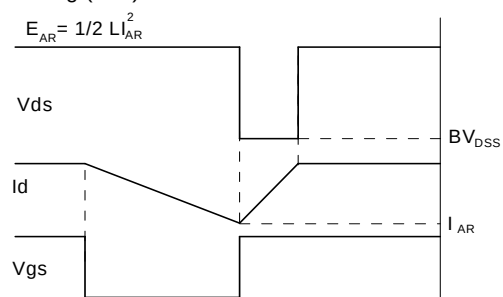
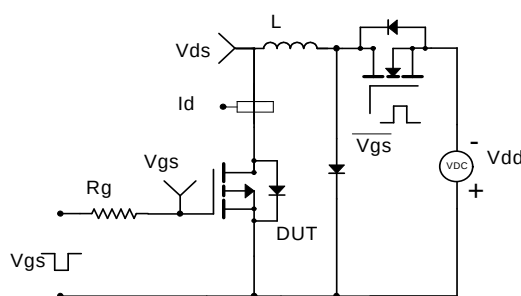
Gate Charge Test Circuit &amp; Waveform



Resistive Switching Test Circuit &amp; Waveforms



Unclamped Inductive Switching (UIS) Test Circuit &amp; Waveforms



Diode Recovery Test Circuit &amp; Waveforms

